April 1988 Revised September 2000 74F139 Dual 1-of-4 Decoder/Demultiplexer

FAIRCHILD

SEMICONDUCTOR

74F139 Dual 1-of-4 Decoder/Demultiplexer

General Description

The F139 is a high-speed, dual 1-of-4 decoder/demultiplexer. The device has two independent decoders, each accepting two inputs and providing four mutually exclusive active LOW outputs. Each decoder has an active LOW Enable input which can be used as a data input for a 4-output demultiplexer. Each half of the F139 can be used as a function generator providing all four minterms of two variables.

Ordering Code:

Order Number	Package Number	Package Description			
74F139SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow			
74F139SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide			
74F139PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide			

Features

Multifunction capability

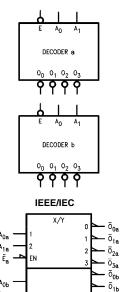
■ Two completely independent 1-of-4 decoders

■ Active LOW mutually exclusive outputs

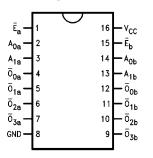
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code

ō₂₅ ō₃₅

Logic Symbols



Connection Diagram



Truth Table

	Inputs		Outputs					
E	A ₀	A ₁	\overline{O}_0	\overline{O}_1	\overline{O}_2	\overline{O}_3		
Н	Х	Х	Н	Н	Н	Н		
L	L	L	L	н	н	н		
L	н	L	н	L	Н	н		
L	L	н	н	н	L	н		
L	н	н	н	н	н	L		
H = HIGH Voltage Level								

L = LOW Voltage Level

X = Immaterial

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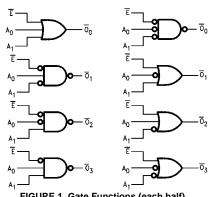
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Unit Loading/Fan Out

Dia Managa	Description	U.L.	Input I _{IH} /I _{IL}	
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
A ₀ , A ₁	Address Inputs	1.0/1.0	20 µA/-0.6 mA	
Ē	Enable Inputs (Active LOW)	1.0/1.0	20 µA/–0.6 mA	
$\overline{O}_0 - \overline{O}_3$	Outputs (Active LOW)	50/33.3	–1 mA/20 mA	

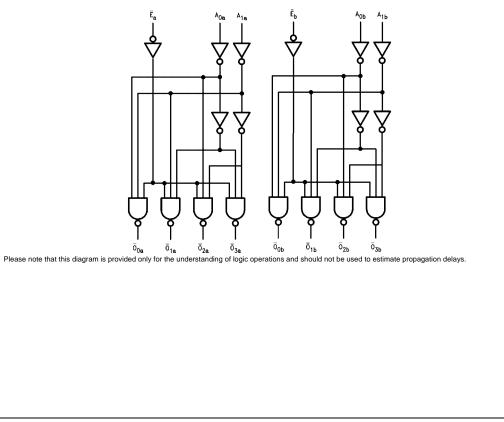
Functional Description

The F139 is a high-speed dual 1-of-4 decoder/demultiplexer. The device has two independent decoders, each of which accepts two binary weighted inputs (A_0-A_1) and provides four mutually exclusive active LOW Outputs ($\overline{O}_0 - \overline{O}_3$). Each decoder has an active LOW enable (\overline{E}). When \overline{E} is HIGH all outputs are forced HIGH. The enable can be used as the data input for a 4-output demultiplexer application. Each half of the F139 generates all four minterms of two variables. These four minterms are useful in some applications, replacing multiple gate functions as shown in Figure 1, and thereby reducing the number of packages required in a logic network.





Logic Diagram



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Absolute Maximum Ratings(Note 1)

	-	~
Storage Temperature	-65°C to +150°C	С
Ambient Temperature under Bias	$-55^{\circ}C$ to $+125^{\circ}C$	F
Junction Temperature under Bias	$-55^{\circ}C$ to $+150^{\circ}C$	S
V _{CC} Pin Potential to Ground Pin	-0.5V to +7.0V	
Input Voltage (Note 2)	-0.5V to +7.0V	
Input Current (Note 2)	-30 mA to +5.0 mA	
Voltage Applied to Output		
in HIGH State (with $V_{CC} = 0V$)		
Standard Output	–0.5V to V _{CC}	No
3 STATE Output	-0.5V to +5.5V	ma un
Current Applied to Output		No
in LOW State (Max)	twice the rated I_{OL} (mA)	
ESD Last Passing Voltage (Min)	4000V	

Recommended Operating Conditions

Free Air Ambient Temperature Supply Voltage

74F139

0°C to +70°C +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

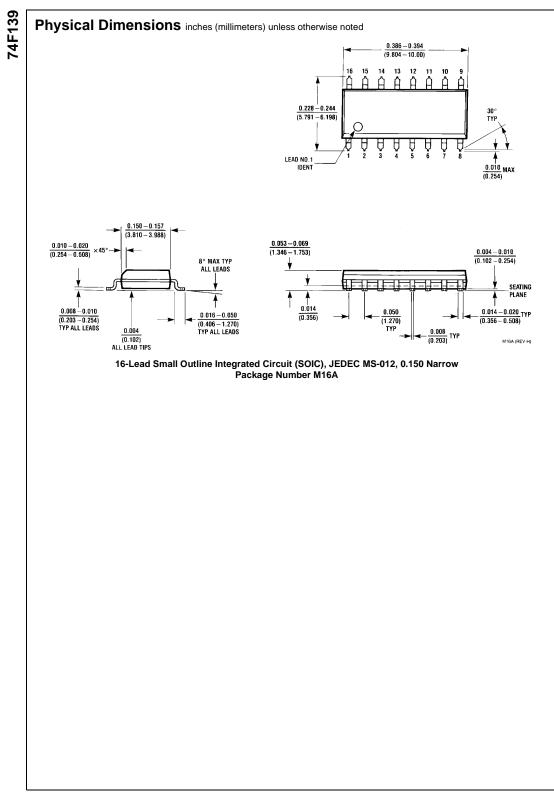
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

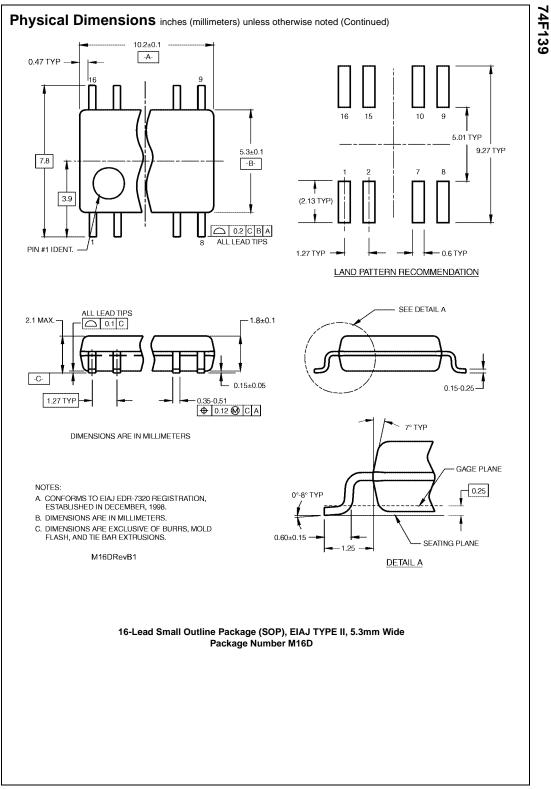
DC Electrical Characteristics

Symbol	Parameter		Min	Тур	Max	Units	Vcc	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH Voltage 10% V _{CC}		2.5			V	Min	$I_{OH} = -1 \text{ mA}$
		5% V _{CC}	2.7			,		$I_{OH} = -1 \text{ mA}$
V _{OL}	Output LOW Voltage	10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA
I _{IH}	Input HIGH Current				5.0	μΑ	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdo	wn Test			7.0	μΑ	Max	V _{IN} = 7.0V
ICEX	Output HIGH Leakage Curre	nt			50	μΑ	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test		4.75			V	0.0	I _{ID} = 1.9 μA
								All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current				3.75	μA	0.0	V _{IOD} = 150 mV
						μΑ		All Other Pins Grounded
IIL	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$
los	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V
I _{CC}	Power Supply Current			13	20	mA	Max	

AC Electrical Characteristics

Symbol	Parameter	T _A = +25°C V _{CC} = +5.0V C _L = 50 pF			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	3.5	5.3	7.5	3.0	8.5	
t _{PHL}	A_0 or A_1 to \overline{O}_n	4.0	6.1	8.0	4.0	9.0	ns
t _{PLH}	Propagation Delay	3.5	5.4	7.0	3.5	8.0	ns
t _{PHL}	E ₁ to O _n	3.0	4.7	6.5	3.0	7.5	115





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